

Notice of References Cited	Application/Control No. 10/594,499	Applicant(s)/Patent Under Reexamination KURODA ET AL.	
	Examiner KEZHEN SHEN	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0137915 A1	07-2003	Shoji et al.	369/59.25
*	B	US-6,656,560 B2	12-2003	Yamamoto et al.	428/64.4
*	C	US-2004/0062188 A1	04-2004	Yamamoto et al.	369/275.3
*	D	US-2004/0120241 A1	06-2004	Kobayashi et al.	369/094
*	E	US-2004/0105351 A1	06-2004	Ueki, Yasuhiro	369/030.23
*	F	US-2005/0013222 A1	01-2005	Lee et al.	369/047.51
*	G	US-2005/0174902 A1	08-2005	Fujita, Shinji	369/047.15
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.